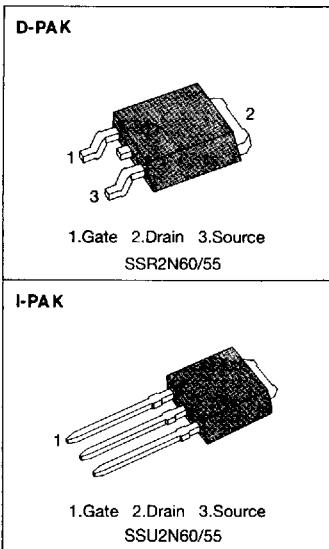


## FEATURES

- Lower R<sub>DS(ON)</sub>
- Improved Inductive Ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability



## PRODUCT SUMMARY

Part Number	V <sub>DS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
SSR2N60/U2N60	600V	5.0 Ω	2.0A
SSR2N55/U2N55	550V	5.0 Ω	2.0A

## ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	SSR2N60 SSU2N60	SSR2N55 SSU2N55	Unit
Drain-Source Voltage (1)	V <sub>DSS</sub>	600	550	Vdc
Drain-Gate Voltage (R <sub>G</sub> =1MΩ)(1)	V <sub>DGR</sub>	600	550	Vdc
Gate-Source Voltage	V <sub>GS</sub>	±20		Adc
Continuous Drain Current T <sub>C</sub> =25 °C	I <sub>D</sub>	2.0	2.0	Adc
Continuous Drain Current T <sub>C</sub> =100 °C	I <sub>D</sub>	1.3	1.3	Adc
Drain Current - Pulsed (3)	I <sub>DM</sub>	8.0	8.0	Adc
Single Pulsed Avalanche Energy (4)	E <sub>AS</sub>	68	68	mJ
Avalanche Current	I <sub>AS</sub>	2.0	2.0	A
Total Power Dissipation T <sub>C</sub> =25 °C	P <sub>D</sub>	42	42	Watts
Derate Above 25 °C		0.33	0.33	W/ °C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 ~ +150		°C
Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds	T <sub>L</sub>	300		°C

Notes : (1) T<sub>J</sub>=25°C to 150°C

(2) Pulse test : Pulse width ≤ 300μs, Duty Cycle ≤ 2%

(3) Repetitive rating : Pulse width limited by junction temperature

(4) L= 31mH, V<sub>DD</sub>=50V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25°C

**ELECTRICAL CHARACTERISTICS** ( $T_C=25^\circ C$  unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV <sub>dss</sub>	Drain-Source Breakdown Voltage SSR2N60/U2N60	600	-	-	V	$V_{GS}=0V$ , $I_D=250\mu A$
	SSR2N55/U2N55	550	-	-	V	
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	-	4.0	V	$V_{DS}=V_{GS}$ , $I_D=250\mu A$
I <sub>GS</sub>	Gate-Source Leakage Forward	-	-	100	nA	$V_{GS}=20V$
I <sub>GS</sub>	Gate-Source Leakage Reverse	-	-	-100	nA	$V_{GS}=-20V$
I <sub>GS</sub>	Zero Gate Voltage Drain Current	-	-	250	$\mu A$	$V_{DS}=\text{Max. Rating}$ , $V_{GS}=0V$
		-	-	1000	$\mu A$	$V_{DS}=0.8 \text{ Max. Rating}$ , $V_{GS}=0V$ , $T_C=150^\circ C$
R <sub>D(on)</sub>	Static Drain-Source On-Resistance (2)	-	-	5.0	$\Omega$	$V_{GS}=10V$ , $I_D=1.0A$
g <sub>f</sub>	Forward Transconductance (2)	1.4	-	-	$\Omega$	$V_{GS}=50V$ , $I_D=1.0A$
C <sub>iss</sub>	Input Capacitance	-	550	-	pF	$V_{GS}=0V$ , $V_{DS}=25V$ , $f=1MHz$
C <sub>oss</sub>	Output Capacitance	-	38	-	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance	-	17	-	pF	
t <sub>d(on)</sub>	Turn-On Delay Time	-	20	-	ns	$V_{DD}=0.5 BV_{dss}$ , $I_D=2.0A$ , $Z_0=24 \Omega$ , $V_{GS}=10V$ (MOSFET switching times are essentially independent of operating temperature)
t <sub>r</sub>	Rise Time	-	15	-	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	-	55	-	ns	
t <sub>f</sub>	Fall Time	-	25	-	ns	
Q <sub>g</sub>	Total Gate Charge (Gate-Source Pulse Gate-Drain)	-	-	35	nC	$V_{GS}=10V$ , $V_{DS}=2.0A$ , $V_{DS}=0.8 \text{ Max. Rating}$ (Gate charge is essentially independent of operating temperature)
Q <sub>gs</sub>	Gate-Source Charge	-	3.0	-	nC	
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	-	12	-	nC	

**THERMAL RESISTANCE**

Symbol	Characteristics		All	Units	Remark
R <sub>thJC</sub>	Junction-to-Case	MAX	3.0	K/W	
R <sub>thCS</sub>	Case-to-sink	TYP	1.7	K/W	Mounting surface flat, smooth and greased
R <sub>thJA</sub>	Junction-to-Ambient	MAX	110	K/W	Free Air Operation

Notes : (1)  $T_J=25^\circ C$  to  $150^\circ C$

(2) Pulse test : Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

(3) Repetitive rating : Pulse width limited by max. junction temperature